



## Certified Reference Material

## Certificate of Analysis

ISO 17034:2016

ISO/IEC 17025:2017

Revision No.: 000 Revision Date: 07/25/2022



Product ID: IARM-CU954-21

Product Description: Aluminum Bronze, CDA 954 / C95400

**Description and Intended Use:** This **Certified Reference Material** is covered under the scope of accreditation to **ISO 17034** by LGC Standards - Manchester, NH. As an ISO 17034 certified reference material, appropriate use of this material will fulfill the certified reference material and traceability requirements for use in **ISO 17025** accredited laboratories. This CRM may come in the form of a solid disk, or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

Certified Values listed in wt.% with associated uncertainties											
Ag	0.0012	±0.0002	Αl	10.55	±0.05	Bi	0.0009	±0.0005	Co	0.002	$\pm 0.001$
Cr	0.022	±0.002	Cu	85.1	±0.1	Fe	3.66	±0.04	Mg	0.0013	$\pm 0.0003$
Mn	0.393	±0.005	Ni	0.105	±0.004	Р	0.0031	±0.0008	Pb	0.012	$\pm 0.001$
S	0.0019	±0.0008	Sb	0.0019	±0.0007	Si	0.029	±0.002	Sn	0.0053	$\pm 0.0006$
Zn	0.029	±0.002									

## Indicative Values listed in ppm

As (20) Be (4) C (50) Cd (8) Se (30) Se (30) Zr (7)

Homogeneity and Uncertainty: "Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where N<sub>prod</sub> is the number of units produced and N<sub>min</sub> is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity may also be determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculated uncertainty due to inhomogeneity (U<sub>nom</sub>). Uncertainty of the material is calculated by equation 2, where H=U<sub>hom</sub>, S= Standard deviation, t= t-value at 95% CI, and n= number of observations.

1. 
$$N_{MIN} = \max(10, \sqrt[3]{N_{PROD}})$$
 2.  $U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$ 

Certification Laboratories: Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised reference materials. Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

- Dirats Laboratories Westfield, MA
- IMR Test Labs Lousiville, KY
   ApplyorCort Applytical Rigginsol
- AnchorCert Analytical Birmingham, UK
- Applied Technical Services Marietta, GA
- New Hampshire Materials Laboratory. Inc Somersworth, NH
- LGC Standards Manchester, NH
- NSL Analytical Services Cleveland, OH
- SGS MSi Melrose Park, IL

- Scrooby's Laboratory Service Benoni, South Africa
- TCR Engineering Services Pvt. Ltd. Mumbai, India
- Analyticka Labortor Lithea S.R.O Brno, Czech Republic

Instructions for Use: The test surface is on the opposite side of the labeled surface, which includes the material identification. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams. The material should be stored in a cool, dry location when not in use.

Chips are not recommended for gas analysis.

Period of Validity: The certification of this material is valid indefinitely, within the uncertainty specified, provided the material is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the material is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

Chuck Goudreau, Certifying Officer

July 25, 2022 Certification Dat



ISO 17034 Accredited: Reference Materials
Producer, Certificate # 2848.02
ISO/IEC 17025 Accredited: Chemical
Testing, Certificate # 2848.01



## The following data represents all pertinent information reported as it applies to the chemical characterization of this material.

	Ag	Al	As	Be	Bi	С	Cd	Co	Cr	Cu	Fe	Mg	Mn
1	0.0009	10.410	0.0003	0.00003	0.0001	0.0012	0.0003	0.0007	0.0180	84.800	3.5570	0.0010	0.3780
2	0.0010	10.410	0.0004	0.0002	0.0004	0.0023	0.0006	0.0009	0.0180	84.868	3.5821	0.0010	0.3810
3	0.0010	10.483	0.0004	0.0010	0.0004	0.0040	0.0010	0.0009	0.0187	84.930	3.5970	0.0012	0.3827
4	0.0010	10.500	0.0007	<0.0001	0.0010	0.0050	0.0012	0.0010	0.0190	85.011	3.5970	0.0012	0.3875
5	0.0010	10.500	0.0009	<0.0005	0.0010	0.0060	<0.0001	0.0013	0.0207	85.100	3.6005	0.0013	0.3890
6	0.0010	10.548	0.0010	<0.001	0.0011	0.0061	<0.0001	0.0031	0.0210	85.102	3.6085	0.0013	0.3900
7	0.0011	10.580	0.0010	<0.001	0.0013	0.0064	< 0.0005	0.0036	0.0214	85.103	3.6234	0.0019	0.3902
8	0.0014	10.585	0.0048	<0.0010	0.0019	0.0080	<0.001	0.0037	0.0220	85.150	3.6500	<0.0010	0.3920
9	0.0014	10.602	0.0120	<0.002	<0.001	<0.0050	<0.001	< 0.0005	0.0226	85.200	3.6700	<0.010	0.3959
10	0.0015	10.610	<0.001		<0.0010		<0.0010	<0.0010	0.0228	85.240	3.6800		0.4000
11	0.0015	10.617	<0.002		<0.002		< 0.002	< 0.002	0.0230	85.283	3.6900		0.4000
12	0.0016	10.620	<0.002		<0.002		<0.002	<0.002	0.0232		3.6920		0.4010
13	< 0.002	10.627	<0.002				<0.002	< 0.005	0.0240		3.7050		0.4015
14	< 0.002		<0.0050						0.0270		3.7100		0.4040
15									0.0282		3.7600		0.4060
16											3.8400		
Mean	0.0012	10.546	0.0024	0.0004	0.0009	0.0049	0.0008	0.0019	0.0220	85.072	3.6602	0.0013	0.3933
STDV	0.0003	0.0775	0.0039	0.0005	0.0006	0.0023	0.0004	0.0013	0.0030	0.1541	0.0738	0.0003	0.0087
Certified	0.0012	10.55	(0.002)	(0.0004)	0.0009	(0.005)	(0.0008)	0.002	0.022	85.1	3.66	0.0013	0.393
Ucrm	0.0002	0.05			0.0005			0.001	0.002	0.1	0.04	0.0003	0.005
Methods	I,IM,O,G,X	I,G,O,X	I,IM,O,X	I,O,G,IM	I,IM,O,X	C,G	I,IM,O,G,X	I,IM,O,G,X,A	I,O,G,IM,X	I,G,O,X,W	I,O,G,X	I,IM,O,X	I,G,IM,O,X

	Ni	Р	Pb	S	Sb	Se	Si	Sn	Zn	Zr
1	0.0954	0.0007	0.0100	0.0005	0.0006	0.0002	0.0217	0.0030	0.0237	0.0003
2	0.0980	0.0019	0.0100	0.0010	0.0008	0.0010	0.0220	0.0040	0.0240	0.0008
3	0.0990	0.0028	0.0100	0.0019	0.0013	0.0010	0.0258	0.0045	0.0250	0.0010
4	0.1010	0.0030	0.0103	0.0020	0.0020	0.0010	0.0270	0.0050	0.0252	<0.0001
5	0.1015	0.0030	0.0106	0.0021	0.0020	0.0010	0.0275	0.0050	0.0260	<0.001
6	0.1029	0.0030	0.0107	0.0028	0.0025	0.0057	0.0280	0.0050	0.0288	<0.0010
7	0.1050	0.0030	0.0119	0.0030	0.0025	0.0109	0.0281	0.0051	0.0290	< 0.002
8	0.1056	0.0032	0.0130	<0.0010	0.0031	<0.002	0.0290	0.0054	0.0290	<0.002
9	0.1060	0.0037	0.0130	<0.002	<0.0010	<0.002	0.0303	0.0057	0.0290	<0.0020
10	0.1100	0.0050	0.0140	<0.005	<0.002	<0.0050	0.0306	0.0060	0.0294	
11	0.1100	0.0050	0.0142		<0.002		0.0309	0.0060	0.0298	
12	0.1165	<0.0020	0.0143				0.0310	0.0060	0.0300	
13	0.1200	< 0.005	0.0146				0.0320	0.0066	0.0303	
14		< 0.0050					0.0320	0.0070	0.0349	
15							0.0330		0.0378	
16							<0.01			
Mean	0.1055	0.0031	0.0120	0.0019	0.0019	0.0030	0.0286	0.0053	0.0288	0.0007
STDV	0.0072	0.0012	0.0019	0.0009	0.0009	0.0040	0.0034	0.0010	0.0039	0.0004
Certified	0.105	0.0031	0.012	0.0019	0.0019	(0.003)	0.029	0.0053	0.029	(0.0007)
U <sub>CRM</sub>	0.004	0.0008	0.001	0.0008	0.0007		0.002	0.0006	0.002	
Methods	I,G,IM,O,X	I,O,IM,X,W	I,IM,O,X,A	I,C,X,O	I,IM,X,O,A	I,O,G,IM,X	I,O,G,IM,X,W	I,IM,O,X	I,O,IM,X,A	I,IM,X

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES